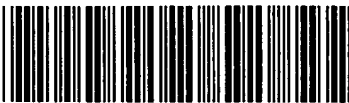


Search Notes

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10/723,037

Examiner

Jinhee J. Lee

Applicant(s)/Patent under
Reexamination

KLIER, JAN

Art Unit

2174

SEARCHED

Class	Subclass	Date	Examiner
715	text	11/26/2006	LEE

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
715	as above	11/26/2006	LEE

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East text search attached	11/26/2006	LEE